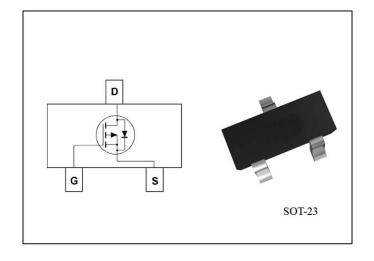


#### Feature

-20V/-3A, RDS(ON) =  $120m\Omega(MAX)$  @VGS = -4.5V. RDS(ON) =  $150m\Omega(MAX)$  @VGS = -2.5V. Super High dense cell design for extremely low RDS(ON) Reliable and Rugged SOT-23 for Surface Mount Package



### Applications

Power Management

Portable Equipment and Battery Powered Systems.

### ● Absolute Maximum Ratings TA=25°CUnless Otherwise noted

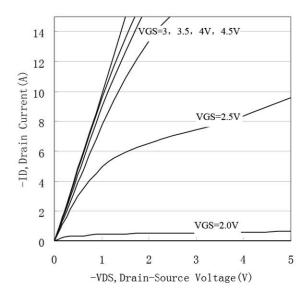
Parameter	Symbol	Limit	Units
Drain-Source Voltage	$V_{DS}$	-20	V
Gate-Source Voltage	V <sub>GS</sub>	±10	V
Drain Current-Continuous	$I_D$	-3	A

#### • Electrical Characteristics TA=25°C Unless Otherwise noted

Parameter	Symbol	Test Conditions	Min	Тур.	Max	Units
Off Characteristics			-			
Drain to Source Breakdown Voltage	BVDSS	VGS=0V, ID=-250μA	-20	-	-	V
Zero-Gate Voltage Drain Current	IDSS	VDS=-20V, VGS=0V		-	-1	μA
Gate Body Leakage Current, Forward	IGSSF	VGS=10V, VDS=0V		-	100	nA
Gate Body Leakage Current, Reverse	IGSSR	VGS=-10V, VDS=0V	-	-	-100	nA
On Characteristics						
Gate Threshold Voltage	VGS(th)	VGS= VDS, ID=-250μA	-0.4	; <b>-</b> ;	-1.0	V
Static Drain-source	RDS(ON)	VGS =-4.5V, ID =-3.0A	-		120	mΩ
On-Resistance	encodestrates (New year of the	VGS =-2.5V, ID =-2.0A	-   -		150	mΩ
Drain-Source Diode Characterist	ics and Maximum	Ratings				
Drain-Source Diode Forward Voltage	VSD	VGS =0V, IS=-1.25A			-1.2	V



## **Typical Characteristics**



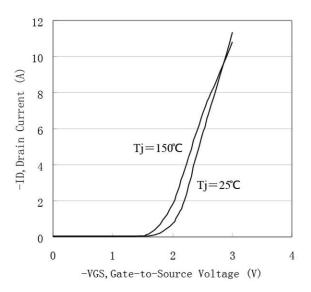
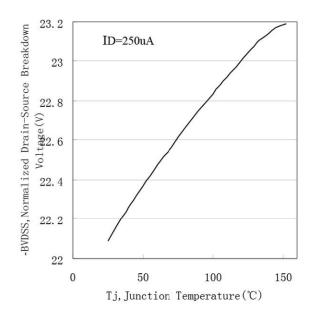


Figure 1. Output Characteristics

Figure 2. Transfer Characteristics





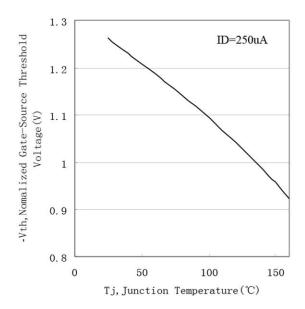
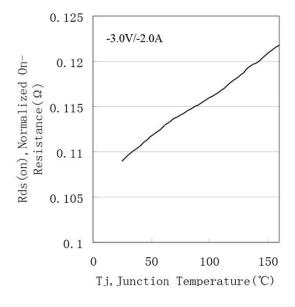


Figure 4. Gate Threshold Variation with Temperature



### **Typical Characteristics**



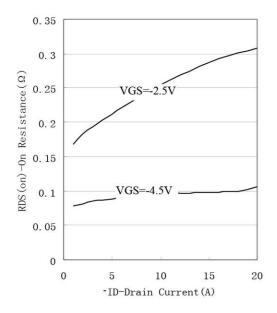
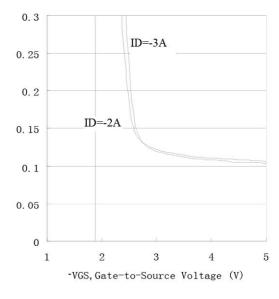
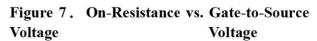


Figure 5. On-Resistance Variation with Temperature

Figure 6. On-Resistance vs. Drain Current





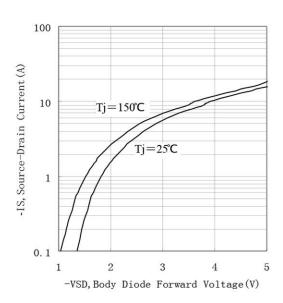


Figure 8. Source-Drain Diode Forward



# Package Outline Dimensions (UNIT: mm)

## SOT-23

